



International Quality and Accreditation Services Pvt. Ltd.
(Formerly International Quality AND Accreditation Services LLP)
25/33, 2nd Floor, East Patel Nagar New Delhi, 110008

Scope of Accreditation for Testing
As per ISO/IEC 17025:2017

CAB Name PLANET ELECTRO LABS PRIVATE LIMITED
Address WZ-407/B-1, Basai Dara Pur Near Ramesh Nagar Metro
Station New Delhi-110015
Certificate No T-0003

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Issue date: 28.12.2024
Validity: 27.12.2028
Amendment date: 30.05.2025

S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
Electronics - Audio Equipment					
1	Headset Microphone Electro-Dynamic	Acoustic Quality of earphone	Quantitative UPTO 100 dB	JSS 55420, Cl. 13.9	Permanent
2		Acoustic Quality Test of Microphone	Quantitative UPTO 100 dB	JSS 55420, Cl. 13.9	Permanent
3		Dimension	Quantitative 1 mm-5000mm, 0.01mm to 150 mm	JSS 55420, Cl. 13.1.2	Permanent
4		Impedance Microphone	Quantitative UPTO 2M Ω	JSS 55420, Cl. 13.4	Permanent
5		Impedance earphone	Quantitative UPTO 2M Ω	JSS 55420, Cl. 13.4	Permanent
6		Insulation Resistance	1M Ω to 2000 M Ω	JSS 55420, Cl. 13.3	Permanent
7		Visual examination with respect to finish, workmanship and assembly confirms to Laid down standards	Qualitative (Visual Inspection)	JSS 55420, Cl. 13.1.1	Permanent
8		voltage proof Test	Qualitative (Visual Inspection)	JSS 55420, Cl. 13.2	Permanent
9		Weight	Quantitative UPTO 1000 gm	JSS 55420, Cl. 13.1.4	Permanent
10	Ear Phone, Electrodynamics	Acoustic Quality	Quantitative UPTO 100 dB	JSS 55400, Cl. 13.4	Permanent
11		Dimensions	Quantitative 1 mm-5000mm, 0.01mm to 150 mm	JSS 55400, Cl. 13.1.2	Permanent
12	Ear Phone, Electrodynamics	Impedance	Quantitative UPTO 2M Ω	JSS 55400, Cl. 13.5	Permanent
13		Insulation Resistance	1M Ω to 2000 M Ω	JSS 55400, Cl. 13.3	Permanent

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S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
14		Visual examination with respect to finish, workmanship and assembly confirms to laid down standards	Qualitative	JSS 55400, Cl. 13.1.1	Permanent
15		Voltage Proof	Qualitative (Visual Inspection)	JSS 55400, Cl. 13.2	Permanent
16		Weights	Quantitative upto 100 kg	JSS 55400, Cl. 13.1.4	Permanent
Electronics -Telecommunication Equipment					
17	Handset	Acoustic Quality of Earphone	Quantitative UPTO 100 dB	JSS 55420, Cl. No. 13.9	Permanent
18		Acoustic Quality of Microphone	Quantitative UPTO 100 dB	JSS 55420, Cl. No. 13.9	Permanent
19		Dimensions	Quantitative 1 mm-5000mm, 0.01mm to 150 mm	JSS 55420, Cl. No. 13.1.2	Permanent
20		Impedance of earphone	Quantitative UPTO 2MΩ	JSS 55420, Cl. No. 13.4	Permanent
21		Impedance of Microphone	Quantitative UPTO 2MΩ	JSS 55420, Cl. No. 13.4	Permanent
22	Handset	Insulation Resistance	1MΩ to 2000 MΩ	JSS 55420, Cl. No. 13.3	Permanent
23		Visual examination with respect to finish, workmanship and assembly confirms to laid down standards	Qualitative	JSS 55420, Cl. No. 13.1.1	Permanent
24		Voltage Proof	Qualitative (Visual Inspection)	JSS 55420, Cl. No. 13.2	Permanent
25	Field Telephone set	Visual Examination with respect to Finish, Workmanship and	Qualitative (Visual Inspection)	JSS 5805-04, Cl 11.1	Permanent

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S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
		Assembly conform to laid down standards			
26		Weight	Quantitative UPTO 1000 gm	JSS 5805-04, CI 11.2	Permanent
27		Insulation Resistance	1MΩ to 2000 MΩ	JSS 5805-04, CI 11.10.1	Permanent
28	Data Transmission Equipment Operating in the 2.4 GHz ISM Band	Adaptivity	Qualitative	CL. 4.2.2 . ETSI EN 300 328 V2.2.2	Permanent
29		Duty Cycle, TX sequence, TX-gap	Qualitative	CL.4.3.1.3 . ETSI EN 300 328 V2.2.2	Permanent
30		Hopping Frequency Separation	0.001kHz to 26.5 GHz	CL.4.3.1.5 . ETSI EN 300 328 V2.2.2	Permanent
31		Medium Utilization	Qualitative	CL. 4.3.1.6 . ETSI EN 300 328 V2.2.2	Permanent
32		Occupied Channel Bandwidth	0.001kHz to 26.5 GHz	CL. 4.3.1.8 . ETSI EN 300 328 V2.2.2	Permanent
33		Accumulated Transmit Time, Frequency Occupation and Hopping Sequence	Qualitative	CL.CSN ETSI EN 300 328 V2.2.2	Permanent
34		Power spectral Density (Conductive only)	0.001kHz to 26.5 GHz	CL.5.4.3 . ETSI EN 300 328 V2.2.2	Permanent
35		RF Output Power (Conductive only)	-80 dBm to +20dBm	CL.4.3.1.2 . ETSI EN 300 328 V2.2.2	Permanent
36		Transmitter Unwanted Emission in OOB Domain	0.001kHz to 26.5 GHz	CL.4.3.1.9 CSN ETSI EN 300 328 V2.2.2	Permanent
37		Walkie -talkie	Cold Test & Heat Test	Qualitative	IS/IEC 60068-2-1
Electronics - IT Equipment					
38	Laptop desktop Computer / Note book computer external Power Adapter Battery Charger, Audio Equipment Combination	Standby Mode Power Consumption	Qualitative	Cl.5 BEE Schedule11,Cl.4, Cl.5 BEE Schedule14,IEC 62301 Ed2	Permanent

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S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
	Unit (TV and DVD, VCR and DVD) Office Equipment (Printers, Scanners, Copiers, Fax Machines and Multifunction Devices)				
39	Desktop Computer Note book Computer	Power Measurement- Off Mode - Sleep Mode - Idle State	1W to 5000 W	IEC 62301 Ed2	Permanent
40	Desktop Computer Note book Computer	Power Measurement- Off Mode - Sleep Mode- Idle State	1W to 5000 W	IEC62623	Permanent
41	Office Equipment (Printers, Scanners, Copiers, Fax Machines and Multifunction Devices)	Power Measurement in ON Mode, OFF Mode, Sleep Mode	1W to 5000 W	IEC 62301 Ed2	Permanent
42	UPS	Thermography test in load conditions with digital Thermography camera meter.	-20 °C to 400 °C	IS 16242-3 (IEC 62040-3)	Permanent
43		Input / Output Phase sequence test with phase sequence meter digital.	Qualitative 60-600 V (3 phase AC) 20Hz – 400Hz	IS 16242-3 (IEC 62040-3)	Permanent
44	UPS	Input / Output power test with Power Analyzer testing unit.	1V – 300V 0.01A – 50 A	IS 16242-3 (IEC 62040-3)	Permanent
45		Battery impedance test by impedance Meter.	Qualitative 40mΩ - 40Ω	IS 16242-3 (IEC 62040-3)	Permanent
Electronics - Electronic Appliances and Accessories					
46	LED Display /TV	Luminance	Qualitative	Cl.6.5, IEC 62087-1, Cl. 6.5, IEC 62087-3	Permanent

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47	LED Display /TV	Luminance	Qualitative	Cl.5 of BEE Schedule 11 & Cl. 4 of BEE Schedule 26, Cl. 5.1.7, IEC 62087-1	Permanent
48	LED Display /TV	Luminance	Quantitative	Cl.5 of BEE Schedule 11& Cl.4 of BEE Schedule 26, Cl. 6..5, IEC62087-3	Permanent
49	LED Display /TV	Measurement of power consumption in ,Partial On mode	1W to 5000 W	Cl.5 of BEE Schedule 11& Cl. 4 of BEE Schedule 26, Cl. 6.6 of IEC 62087-3	Permanent
50	LED Display /TV	Measurement of power consumption in Off mode	1W to 5000 W	Cl.5 of BEE Schedule 11 & Cl. 4 of BEE Schedule26, Cl. 6.7 of IEC 62087-3	Permanent
51	LED Display /TV	ON Mode Power Consumption	1W to 5000 W	Cl.6.4,IEC 62087-3	Permanent
52	LED Display /TV	ON Mode Power Consumption	1W to 5000 W	Cl.5 of BEE Schedule 11& Cl. 4 of BEE Schedule 26, Cl. 6.4, IEC62087-1	Permanent
53	LED Display /TV	ON Mode Power Consumption	1W to 5000 W	Cl.5 of BEE Schedule 11&Cl. 4 of BEE Schedule 26, Cl. 5.3 IEC 62301	Permanent
54	LED Display/ TV	ON Mode Power Consumption	1W to 5000 W	Cl.5 of BEE Schedule 11& Cl. 4of BEE Schedule 26, Cl. 6.4, IEC 62087-3	Permanent
55	LED Display/ TV	Stand by Mode Power Consumption	1W to 5000 W	Cl.5 of BEE Schedule 11 & Cl. 4 of BEE Schedule 26, Cl. 5.3 IEC 62301	Permanent

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Electronics -Environmental Test Facility					
56	Tactical light	Temperature Conditioning	Qualitative upto -50°C	IS/IEC 60068-2-1	Permanent
57	Dragon Search Light	Temperature Conditioning	Qualitative upto -50°C	IS/IEC 60068-2-1	Permanent
58	FLASHLIGHT	CLIMATIC TESTS	Qualitative	CL. 12 IS 2083	Permanent
59	LED Torch	Cold Test & Heat Test	Qualitative upto -50°C upto 200°C	IS/IEC 60068-2-1	Permanent
Electronics - EMC Facility					
60	Electronic Product	Electrostatic Discharge Immunity Test	Qualitative 0.01-20kV	IEC/EN 61000-4-2, IS 14700-4-2 / IS 6873-2 2/CISPR 14-2 ETSI EN 300 386 V2.2.1	Permanent
61		Electrical Fast Transient (EFT)/ Burst Immunity Test	Qualitative	IEC/EN 61000-4-4, IS 14700-4-4/ ETSI EN 300 386 V2.1.1	Permanent
62		Conducted Radio Frequency Immunity Test (Conducted Susceptibility)	Qualitative	IEC/EN 61000-4-6, IS 14700-4-6, ETSI EN 300 386 V2.1.1	Permanent
63		Voltage Dips Short Interruption & Voltage Variations Immunity Test	Qualitative 1-300V	IEC/EN 61000-4-11, IS 14700-4-11, ETSI EN 300386 V2.1.1	Permanent
64		Voltage Dips Short Interruption	Qualitative 1-300V	IEC/EN 61000-4-29	Permanent
65		Conducted Emission	9kHz-300MHz 9kHz-6GHz	EN 55015/CISPR 15, EN 55011/CISPR 11, EN 55014/CISPR 14, EN 55032/CISPR 32	Permanent
Electronics - Safety Test Facility					

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S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
66	Degrees of protection provided by enclosures for electronic equipment against external mechanical impacts (IK code)	Protection against mechanical impacts (IK 01 to IK 10)	Qualitative	IEC 62262	Permanent
Electronics -Miscellaneous					
67	PHOTOVOLTAIC (PV) MODULES –	Testing (Rating Conditions)	Qualitative up to 1200 Wm-2	Cl.4 IEC 61853-3	Permanent
68	PERFORMANCE TESTING AND ENERGY RATING-	Module Energy collection	Quantitative up to 200 °C	Cl.6 IEC 61853-3	Permanent
69	PART 3- ENERGY RATING OF PV MODULES	Procedure for energy rating	Quantitative upto 1000 kWh	Cl.7 IEC 61853-3	Permanent
70	PHOTOVOLTAIC (PV) MODULES – PERFORMANCE	Marking	Qualitative	Cl.4 IS 16170 (Part1):2014 / IEC 61853-1	Permanent
71	TESTING AND ENERGY RATING-	Testing and pass criteria	Quantitative up to 200 °C	Cl.5 IS 16170 (Part1):2014 / IEC 61853-1	Permanent
72	PART 1- IRRADIANCE AND TEMPERATURE PERFORMANCE MEASUREMENTS AND POWER RATING	Power rating condition	Qualitative Visual	Cl.7 IS 16170 (Part1):2014 / IEC 61853-1	Permanent
73		Procedure for irradiance and Temperature performance measurements	Qualitative	Cl.8 IS 16170 (Part1):2014 / IEC 61853-1	Permanent
74		Rating of power	Qualitative up to 1200 Wm-2 up to 500 Volt up to 40 Amp.	Cl.9 IS 16170 (Part1):2014 / IEC 61853-1	Permanent
75	PHOTOVOLTAIC (PV) MODULES –Test Methods for the Detection of	General	Qualitative Humidity: up to 95% & Temp. up to 85°C	Cl.4.1 of IS 17210 (part-1) IEC TS 62804-1	Permanent

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S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
76	Potential-induced degradation Part-1 Crystalline Silicon	Pre-Stress Test	Qualitative up to 50 Amp.	Cl.4.2 of IS 17210 (part-1) IEC TS 62804-1	Permanent
77		Voltage Stress Test Procedures/Apparatus	Qualitative up to 100vdc, 1min. 24 hrs.up to 200°C	Cl.4.3 /4.3.1of IS 17210 (part-1)/ IEC TS 62804-1	Permanent
78		Stress Method a), testing in damp heat using in environmental chamber	Qualitative Humidity: up to 95% & Temp. up to 85°C)	Cl.4.3.2 of IS 17210 (part-1) / IEC TS 62804-1	Permanent
79		Stress Method b), contacting the surfaces with a conductive electrode	Qualitative Humidity: up to 95% & Temp. up to 85°C)	Cl.4.3.3of IS 17210 (part-1) 2019/ IEC TS 62804-1;IS 16170:Part 1(IEC 61853-1),IS 16170:Part 2:2018(IEC 61853-2),IS 16170:Part 3 (IEC 61853-3)	Permanent
80		Post-stress test	Qualitative (up to 60°C) (Visual Inspection)	Cl.4.4 of IS 17210 (part-1) / IEC TS 62804-1	Permanent
81	MAXIMUM POWER POINT TRACKING EFFICIENCY	STATIC MPPT EFFICIENCY	Quantitative 1V-1000V	Cl.4 , 4.1 of IS 17980 /IEC 62891	Permanent
82	OF GRID CONNECTED PHOTOVOLTAIC INVERTER	CALCULATION OF THE OVERALL EFFICIENCY/OVERALL EFFICEIECY AT STANDARD TEST CONDITIONS (STC)	Quantitative 1V-1000V	Cl.5 of IS 17980 / IEC 62891	Permanent
83		CONVERSION EFFICIENCY	Quantitative 1V-1000V	Clause No. 3.4.2 of IS 17980/ IEC 62891	Permanent
84	Photovoltaic (PV) Modules- performance testing &energy rating –part 4:Standard reference climatic profiles	Standard reference climatic profiles for energy rating	Qualitative	Cl. 4 IS 16170(PART-4)/ IEC 61853-4	Permanent

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85	Fire Detection system	Cold Test & Heat Test	Qualitative	IS/IEC 60068-2-1	Permanent
86	Photovoltaic modules - Extended-stress testing - Part 1: Modules	General	Qualitative	CL.5.1 IEC 63209-1 Edition 1.0	Permanent
87		Physical measurement	Qualitative	CL.5.2 IEC 63209-1 Edition 1.0	Permanent
88		Visual inspection	Qualitative	CL.5.3 IEC 63209-1 Edition 1.0	Permanent
89		Initial stabilization	Qualitative	CL.5.4 IEC 63209-1 Edition 1.0	Permanent
90		Performance	Qualitative	CL.5.5 IEC 63209-1 Edition 1.0	Permanent
91		Insulation test	1M Ω to 2000 M Ω	CL.5.6 IEC 63209-1 Edition	Permanent
92		Wet leakage current	1-500 μ A	CL.5.7 IEC 63209-1 Edition 1.0	Permanent
93		Electroluminescent imaging	Quantitative	CL.5.8 IEC 63209-1 Edition 1.0	Permanent
94		Insulation thickness test	0.01 mm to 150 mm	CL.5.9 IEC 63209-1 Edition 1.0	Permanent
95		Thermal cycling	Quantitative	CL.5.10 IEC 63209-1 Edition 1.0	Permanent
96	Humidity freeze	Quantitative	CL.5.11 IEC 63209-1 Edition 1.0	Permanent	
97	Final stabilization	Qualitative	CL.5.12 IEC 63209-1 Edition	Permanent	
98		General	Qualitative	CL.6.1 IEC 63209-1 Edition 1.0	Permanent
99		Initial characterization.	Qualitative	CL.6.2 IEC 63209-1 Edition 1.0	Permanent
100		Test sequence 1: Thermal fatigue	Qualitative	CL.6.3 IEC 63209-1 Edition 1.0	Permanent

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101	Photovoltaic modules - Extended-stress testing - Part 1: Modules	Test sequence 2: Mechanical Stress	Qualitative	CL.6.4 IEC 63209-1 Edition 1.0	Permanent
102		Test sequence 3: Sequential testing including UV stress to module back	Qualitative	CL.6.5 IEC 63209-1 Edition 1.0	Permanent
103		Test sequence 4: Damp heat	Quantitative	CL.6.6 IEC 63209-1 Edition 1.0	Permanent
104		Test sequence 5: Potential -Induced Degradation (PID) testing	Qualitative	CL.6.7 IEC 63209-1 Edition 1.0	Permanent
Electrical - Cable and Wires					
105	Ethernet LAN Cables CAT-V TO VIII	Dimensional requirements	0.01mm – 150 mm	Cl. 6.4.1IS 14493 (Part 5):/ IEC 61156-5	Permanent
106		Dielectric strength	Qualitative 0.1-5kV	Cl. 6.2.3IS 14493 (Part 5)/ IEC 61156-5	Permanent
107		Return Loss	Qualitative -120 to 100dBm	Cl. 6.3.11IS 14493 (Part 5)/ IEC 61156-5	Permanent
108		Insulation resistance	1MΩ to 2000 MΩ upto 2.5kVA	Cl. 6.2.4IS 14493 (Part 5)/ IEC 61156-5	Permanent
109		Conductor Resistance	1MΩ to 2000 MΩ	Cl. 6.2.1IS 14493 (Part 5) / IEC 61156-5	Permanent
110	Ethernet LAN Cables CAT-V TO VIII	Impact /shrinkage	Qualitative	Cl. 6.4.9/6.5.1 IS 14493 (Part 5) /IEC 61156-5	Permanent
111		Cold Bend Test	Qualitative	Cl. 6.5.7IS 14493 (Part 5)/ IEC 61156-5	Permanent

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112		Material and cable construction	Qualitative	Cl. 5 IS 14493 (Part 5)/ IEC 61156-5	Permanent
Electrical - Environmental Test Facility					
113	ELECTRICAL PRODUCTS	DAMP HEAT	Visual inspection Qualitative Amb. to 96%RH Amb. to 90°C	JSS 55555, TEST NUMBER 10, IEC60068-2-78, IS 9000(PART-5/SEC2), IS 9000 (PART-4) , MIL STD 810 F/G/H Method 507.6	Permanent
114		DRIP ROOF	Visual inspection	JSS 55555, TEST NUMBER 11,IEC 60068-2-18, IS/IEC 60529	Permanent
115		DRIVING RAIN	Visual inspection	JSS 55555, TEST NUMBER 12, IEC 60068-2-18,IS/IEC 60529, MIL 810 F/G/H, Method 506.6	Permanent
116	ELECTRICAL PRODUCTS	DROP	Visual inspection	JSS 55555, TEST NUMBER 13, IEC60068-2-31	Permanent
117		DUST	Visual inspection	JSS 55555,TEST NUMBER 14,IEC60529, ,IEC60598, IS 9000 (PART12), MIL 810 F/G/H Method 510.7	Permanent
118		HIGH TEMPERATURE	Visual inspection upto 200°C	JSS 55555, TEST NUMBER 17, IEC 60068-2-38, IS 9000 -6, MIL 810 F/G/H Method 501.7	Permanent

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25/33, 2nd Floor, East Patel Nagar New Delhi, 110008

Scope of Accreditation for Testing
As per ISO/IEC 17025:2017

CAB Name PLANET ELECTRO LABS PRIVATE LIMITED
Address WZ-407/B-1, Basai Dara Pur Near Ramesh Nagar Metro
Station New Delhi-110015
Certificate No T-0003

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Issue date: 28.12.2024
Validity: 27.12.2028
Amendment date: 30.05.2025

S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
119		DRIPPROOF	Visual inspection	JSS 55555 TESTNUMBER 11, IEC60529, IEC 60598	Permanent
120		IMMERSION	Visual inspection	JSS55555, TESTNUMBER 19, IEC 60079-6, MIL 810 F/G/H Method 512.6	Permanent
121	ELECTRICAL PRODUCTS	LOW TEMPERATURE	Visual inspection upto 200°C	JSS 55555, TESTNUMBER 20, IEC 60068-2-13, IS9000-13, MIL 810 F/G/H Method 502.7	Permanent
122		RAPID TEMPERATURE CYCLING (THERMAL SHOCK)	Visual inspection upto 200°C upto -50°C	JSS 55555, TESTNUMBER 22, IEC60068-2-14, IS/IEC 60068: Part 2: Sec 14, MIL 810 F/G/H Method 503.7	Permanent
Mechanical - Textile					
123	High- Altitude Clothing	Temperature Conditioning	Qualitative	IS/IEC 60068-2-1	Permanent
124	High- Altitude Clothing	Temperature Conditioning	Qualitative	IS 15809:2008+A2	Permanent
125	Gas masks	Temperature Conditioning	Qualitative	IS 9473:2002 +A	Permanent
Mechanical - Plastic and Plastic Product					
126	Test for Flammability of Plastic Materials for Parts in Devices and appliances	Test for Flammability of Plastic Materials for Parts in Devices and appliances	Qualitative	UL 94	Permanent
Mechanical – Thermal					
127	Safety Goggles	Temperature Conditioning	Qualitative	EN 168	Permanent
128	Footwear	Temperature Conditioning	Qualitative	IS 15298 (P-1) ISO 20344, CL. 5.10.3.3	Permanent

This is annexure to 'Certificate of Accreditation' and does not require any signature.

Regd. Office: No. 307/20, 2nd Lane No. 5A, Ranjit Nagar, New Delhi 110008, India



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S.NO.	Parameter/ Materials/ Products tested	Type of Test/Properties measured	Range of measurement	Standard specifications/ Equipment/Techniques used	Facility
129	Suit	Temperature Conditioning	Qualitative	IS 15809+A2 CL. No. (C- 4.3)	Permanent
130	Wrist coupler	Damp heat test	Qualitative	IS 9000 PART-4	Permanent
131	Thermal Suit	Temperature Conditioning	Qualitative	IS 15809+A2 CL. NO. (C- 4.3)	Permanent
132	boots	Temperature Conditioning	Qualitative	IS 15298 (P-1) ISO 20344 CL. 5.10.3.3	Permanent
133	Shield	Temperature Conditioning	Qualitative	IS/IEC 60068-2-1	Permanent
134	tents	Temperature Conditioning	Qualitative	IS 15809:2017+A2	Permanent
135	Jackets	Temperature Conditioning	Qualitative	IS 15809:2017+A2 CL. NO. (C- 4.3)	Permanent
136	NON-METAL HELMET	Temperature Conditioning	Qualitative	IS 15298 (P-1) ISO 20344:2021 CL. 5.10.3.3	Permanent
137	GOGGLES	Temperature Conditioning	Qualitative	EN 168	Permanent
138	EYE-PROTECTORS	Temperature TESTS	Qualitative	IS 7524 (Part1) CL. 4.2.1	Permanent
139	Helmet	Temperature Conditioning	Qualitative	IS 2745+A3 Cl. E-2.1	Permanent
Photometry – Miscellaneous					
140	LED LAMPS, LIGHT ENGINES, AND LUMINAIRES	PHOTOMETRIC AND THERMAL MEASUREMENT	100 lm to 60000 lm 1500 – 13000 K 0 – 100	IESLM-84-14 Clause 6	Permanent
141		MAINTENANCE TEST PROCEDURES	Qualitative	IESLM-84-14 Clause 7	Permanent

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